# Notice of References Cited

Application/Control N 09/847,794	Reexamination	Applicant(s)/Patent Under Reexamination HUFFMAN, JACKIE L.		
Examiner	Art Unit			
Scott L. Jarrett	3623	Page 1 of 2		

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,819,162	04-1989	Webb et al.	705/32
*	В	US-4,930,093	05-1990	Houser et al.	702/186
*	С	US-5,068,787	11-1991	Pipella et al.	705/32
*	D	US-5,121,319	06-1992	Fath et al.	700/83
*	Е	US-5,355,327	10-1994	Stent et al.	702/187
*	F	US-5,535,256	07-1996	Maloney et al.	379/309
*	G	US-5,726,914	03-1998	Janovski et al.	702/84
*	Н	US-6,735,574	05-2004	Bull, Jeffrey A.	705/32
*	1	US-6,970,810	11-2005	Matsko, Michael J.	702/187
*	J	US-7,093,748	08-2006	Matsko et al.	235/377
*	К	US-7,181,413	02-2007	Hadden et al.	705/11
*	L	US-2001/0032120	10-2001	Stuart et al.	705/11
*	М	US-2001/0056367	12-2001	Herbert et al.	705/11

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 97/13229	07-1997	GB	Sensormatic Electronics	G07G 1/12
	0					
	Р					
	Q					
	R					
	s					
	т					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Fitzpatrick, Michael J., Measuring Productivity with Employee Task Charts American Agent & Broker, Vol. 60, No. 10, October 1988, Pages 88, 90
	\ \	Meyer, Christopher, How the Right Measures Helps Teams Excel Harvard Business Review, Vol. 72, No. 3, May-June 1994, Pages 95-103
	w	Grant, Rebecca et al., Computerized Performance Monitors as Multidimensional Systems ACM Transactions on Information SYstems, Vol. 14, No. 2, April 1996, Pages 212-235
	x	Lean Manufacturing Principles Improve Production Metal Forming Magazin, June 1996

<sup>\*</sup>A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

# Notice of References Cited Application/Control No. O9/847,794 Examiner Scott L. Jarrett Application/Control No. Applicant(s)/Patent Under Reexamination HUFFMAN, JACKIE L. Page 2 of 2

# U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
	С	US-			
	D	US-			
	E	US-			
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	J	US-			
	К	US-			
	L	US-			
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## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					,
	0					
	Р					
	Q		•			
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Stansfield, Timothy Char,es, The effects of feedback and goal setting on manufacturing productivity improvement The University of Toledo, 1997, AAT 9816873
	٧	Kaydos, Will, Operational Performance Measurement CRC Press, 1999, ISBN: 1-57444-099-3
	w .	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.